

SNOS085B-MAY 2004-REVISED MAY 2004

54AC74/54ACT74 Dual D-Type Positive Edge-Triggered Flip-Flop

Check for Samples: 54AC74, 54ACT74

FEATURES

- I_{CC} reduced by 50%
- · Output source/sink 24 mA
- 'ACT74 has TTL-compatible inputs
- Standard Microcircuit Drawing (SMD)

'AC74: 5962-88520'ACT74: 5962-87525

 54AC74 now qualified to 300Krad RHA designation, refer to the SMD for more information

DESCRIPTION

The 'AC/'ACT74 is a dual D-type flip-flop with Asynchronous Clear and Set inputs and complementary (Q, \overline{Q}) outputs. Information at the input is transferred to the outputs on the positive edge of the clock pulse. Clock triggering occurs at a voltage level of the clock pulse and is not directly related to the transition time of the positive-going pulse. After the Clock Pulse input threshold voltage has been passed, the Data input is locked out and information present will not be transferred to the outputs until the next rising edge of the Clock Pulse input.

Asynchronous Inputs:

LOW input to \overline{S}_D (Set) sets Q to HIGH level

LOW input to \overline{C}_D (Clear) sets Q to LOW level

Clear and Set are independent of clock

Simultaneous LOW on \overline{C}_D and \overline{S}_D makes both Q and \overline{Q}

HIGH

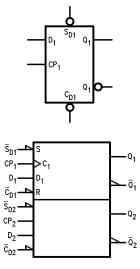


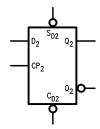
Figure 1. IEEE/IEC

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Pin Names	Description
D ₁ , D ₂	Data Inputs
CP ₁ , CP ₂	Clock Pulse Inputs
$\overline{C}_{D1}, \overline{C}_{D2}$	Direct Clear Inputs
$\overline{S}_{D1}, \overline{S}_{D2}$	Direct Set Inputs
$Q_1, \overline{Q}_1, Q_2, \overline{Q}_2$	Outputs

Connection Diagram

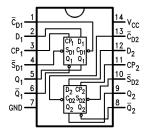


Figure 2. Pin Assignment for DIP and Flatpak

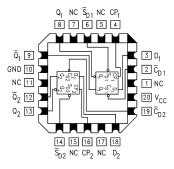


Figure 3. Pin Assignment for LCC

Truth Table

(Each Half)

	Input	Out	puts		
	<u>C</u> _D	СР	D	Q	Q
L	Н	X	Х	Н	L
Н	L	Х	Х	L	Н
L	L	X	Х	Н	Н

(1) H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

= LOW-to-HIGH Clock_Transition

 $Q_0(\overline{Q_0})$ = Previous $Q(\overline{Q})$ before LOW-to-HIGH Transition of Clock

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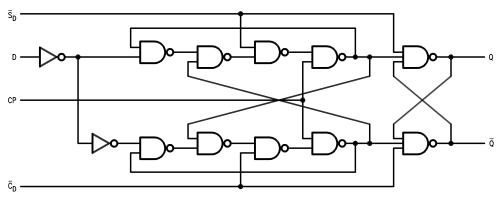
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Truth Table (1) (continued)

(Each Half)

	Input	Out	puts		
<u></u> \$□	<u>C</u> _D	СР	D	Q	Q
Н	Н		Н	Н	L
Н	Н		L	L	Н
Н	Н	L	Х	Q_0	\overline{Q}_0

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings (1)

Supply Voltage (V _{CC})	-0.5V to +7.0V
DC Input Diode Current (I _{IK})	
V _I = −0.5V	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage (V _I)	-0.5V to V _{CC} + 0.5V
DC Output Diode Current (I _{OK})	
$V_{O} = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage (V _O)	-0.5V to V _{CC} + 0.5V
DC Output Source	
or Sink Current (I _O)	±50 mA
DC V _{CC} or Ground Current	
per Output Pin (I _{CC} or I _{GND})	±50 mA
Storage Temperature (T _{STG})	−65°C to +150°C
Junction Temperature (T _J)	
CDIP	175°C

⁽¹⁾ Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT[®] circuits outside databook specifications.

Product Folder Links: 54AC74 54ACT74

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Recommended Operating Conditions

Supply Voltage (V _{CC})	
'AC	2.0V to 6.0V
'ACT	4.5V to 5.5V
Input Voltage (V _I)	0V to V _{CC}
Output Voltage (V _O)	0V to V _{CC}
Operating Temperature (T _A)	
54AC/ACT	−55°C to +125°C
Minimum Input Edge Rate (ΔV/Δt)	
'AC Devices	
V _{IN} from 30% to 70% of V _{CC}	
V _{CC} @ 3.3V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate (ΔV/Δt)	
'ACT Devices	
V _{IN} from 0.8V to 2.0V	
V _{CC} @ 4.5V, 5.5V	125 mV/ns

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DC Characteristics for 'AC Family Devices

			54AC		
Symbol	Parameter	V _{CC}	T _A =	Units	Conditions
		(V)	-55°C to +125°C		
			Guaranteed Limits		
V _{IH}	Minimum High	3.0	2.1		V _{OUT} = 0.1V
	Level Input	4.5	3.15	V	or V _{CC} - 0.1V
	Voltage	5.5	3.85		
V _{IL}	Maximum Low	3.0	0.9		V _{OUT} = 0.1V
	Level Input	4.5	1.35	V	or V _{CC} - 0.1V
	Voltage	5.5	1.65		
V _{OH}	Minimum High	3.0	2.9		I _{OUT} = -50 μA
	Level Output	4.5	4.4	V	
	Voltage	5.5	5.4		
					$V_{IN} = V_{IL} \text{ or } V_{IH}$
		3.0	2.4		−12 mA
		4.5	3.7	V	I _{OH} -24 mA
		5.5	4.7		−24 mA
V _{OL}	Maximum Low	3.0	0.1		I _{OUT} = 50 μA
	Level Output	4.5	0.1	V	
	Voltage	5.5	0.1		
					$V_{IN} = V_{IL} \text{ or } V_{IH}$
		3.0	0.5		12 mA
		4.5	0.5	V	I _{OL} 24 mA
		5.5	0.5		24 mA
I _{IN}	Maximum Input	5.5	±1.0	μΑ	$V_I = V_{CC}$, GND
	Leakage Current				
I _{OLD}	⁽²⁾ Minimum	5.5	50	mA	V _{OLD} = 1.65V Max
I _{OHD}	Dynamic Output Current	5.5	-50	mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent	5.5	40.0	μA	$V_{IN} = V_{CC}$
	Supply Current				or GND

⁽¹⁾ All outputs loaded; thresholds on input associated with output under test.(2) Maximum test duration 2.0 ms, one output loaded at a time.



DC Characteristics for 'ACT Family Devices

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			54ACT		
Symbol	Parameter	V _{CC}	T _A =	Units	Conditions
		(V)	−55°C to +125°C		
			Guaranteed Limits		
V _{IH}	Minimum High	4.5	2.0	V	V _{OUT} = 0.1V
	Level Input Voltage	5.5	2.0		or V _{CC} - 0.1V
V _{IL}	Maximum Low	4.5	0.8	V	V _{OUT} = 0.1V
	Level Input Voltage	5.5	0.8		or V _{CC} - 0.1V
V _{OH}	Minimum High	4.5	4.4	V	I _{OUT} = -50 μA
	Level Output Voltage	5.5	5.4		
	Voltage				$V_{IN} = V_{IL} \text{ or } V_{IH}$
		4.5	3.70	V	I _{OH} -24 mA
		5.5	4.70		−24 mA
V_{OL}	Maximum Low	4.5	0.1	V	I _{OUT} = 50 μA
	Level Output Voltage	5.5	0.1		
					$V_{IN} = V_{IL} \text{ or } V_{IH}$
		4.5	0.50	V	I _{OL} 24 mA
		5.5	0.50		24 mA
I _{IN}	Maximum Input	5.5	±1.0	μΑ	$V_I = V_{CC}$, GND
	Leakage Current				
I _{CCT}	Maximum	5.5	1.6	mA	$V_I = V_{CC} - 2.1V$
	I _{CC} /Input				
I _{OLD}	(2)Minimum	5.5	50	mA	V _{OLD} = 1.65V Max
I _{OHD}	Dynamic Output Current	5.5	- 50	mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent	5.5	40.0	μΑ	$V_{IN} = V_{CC}$
	Supply Current				or GND

⁽¹⁾ All outputs loaded; thresholds on input associated with output under test.

⁽²⁾ Maximum test duration 2.0 ms, one output loaded at a time.



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AC Electrical Characteristics

	Parameter	V _{cc}	$54AC$ $T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $C_L = 50 \text{ pF}$			Fig.
Symbol		(V)			Units	
		(1)				No.
			Min	Max		
f _{max}	Maximum Clock	3.3	70		MHz	
	Frequency	5.0	95			
t _{PLH}	Propagation Delay	3.3	1.0	13.0	ns	
	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	1.0	9.5		
t _{PHL}	Propagation Delay	3.3	1.0	14.0	ns	
	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	1.0	10.5		
t _{PLH}	Propagation Delay	3.3	1.0	17.5	ns	
	CP_n to Q_n or \overline{Q}_n	5.0	1.0	12.0		
t _{PHL}	Propagation Delay	3.3	1.0	13.5	ns	
	CP_n to Q_n or \overline{Q}_n	5.0	1.0	10.0		

⁽¹⁾ Voltage Range 3.3 is $3.3V \pm 0.3V$ Voltage Range 5.0 is $5.0V \pm 0.5V$

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AC Operating Requirements

			54AC		
Symbol	Parameter V _{CC}	V _{CC}	T _A = −55°C to +125°C	Units	Fig.
		(V)	C _L = 50 pF		No.
		(1)	Guaranteed Limits		
t _s	Set-up Time, HIGH or LOW	3.3	5.0	ns	
	D _n to CP _n	5.0	4.0		
t _h	Hold Time, HIGH or LOW	3.3	0.5	ns	
	D _n to CP _n	5.0	0.5		
t _w	CP_n or \overline{C}_{Dn} or \overline{S}_{Dn}	3.3	8.0	ns	
	Pulse Width	5.0	5.5		
t _{rec}	Recovery Time	3.3	0.5	ns	
·	\overline{C}_{Dn} or \overline{S}_{Dn} to CP	5.0	0.5		

⁽¹⁾ Voltage Range 3.3 is 3.3V ± 0.3 V Voltage Range 5.0 is 5.0V ± 0.5 V

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AC Electrical Characteristics

			54	ACT		
		V _{CC}	T _A =	−55°C		Fig.
Symbol	Parameter	(V)	to +	125°C	Units	No.
		(1)	C _L =	50 pF		
			Min	Max		
f _{max}	Maximum Clock	5.0	85		MHz	
	Frequency					
t _{PLH}	Propagation Delay	5.0	1.0	11.5	ns	
	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n					
t _{PHL}	Propagation Delay	5.0	1.0	12.5	ns	
	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n					
t _{PLH}	Propagation Delay	5.0	1.0	14.0	ns	
	CP_n to Q_n or \overline{Q}_n					
t _{PHL}	Propagation Delay	5.0	1.0	12.0	ns	
	CP_n to Q_n or \overline{Q}_n					

⁽¹⁾ Voltage Range 5.0 is 5.0V ±0.5V

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AC Operating Requirements

			54ACT		
Symbol	Parameter	V _{CC}	T _A = −55°C	Units	Fig.
		(V)	C _L = 50 pF		No.
		(1)	Guaranteed Limits		
·s	Set-up Time, HIGH or LOW	5.0	4.0	ns	
	D _n to CP _n				
h	Hold Time, HIGH or LOW	5.0	1.0	ns	
	D _n to CP _n				
w	CP_n or \overline{C}_{Dn} or \overline{S}_{Dn}	5.0	7.0	ns	
	Pulse Width				
rec	Recovery Time	5.0	0.5	ns	
	\overline{C}_{Dn} or \overline{S}_{Dn} to CP				

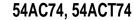
⁽¹⁾ Voltage Range 5.0 is 5.0V ±0.5V

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Capacitance

Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation	35.0	pF	V _{CC} = 5.0V
	Capacitance			

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